

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/669,286	YOSHINO ET AL.	
	Examiner	Art Unit	
	Mark A. Chapman	1756	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
430	108.1	6/13/2005	MC
	124		
	125		